JC05 Rec'd PCT/PTO 21 SEP 2005

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Ryosuke YAMADA et al

Serial No. (new - based on PCT/JP2004/003894)

Int'l Filing Date: March 22, 2004

For:

ANALYSIS APPARATUS AND CELL COUNTING

METHOD IN ANALYSIS APPARATUS

## INFORMATION DISCLOSURE STATEMENT

Customer Window U.S. Patent & Trademark Office Randolph Building 401 Dulany Street Alexandria, VA 22314

Pursuant to 37 C.F.R. §1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached Form PTO-1449, which listing includes references cited in the accompanying International Search Report issued in connection with the International application. The relevancy of the foreign-language documents is indicated in the International Search Report. A copy of the foreign references listed on Form PTO-1449 is attached.

The above information is presented so that the Patent and Trademark Office may, in the first instance, determine any materiality thereof to the claimed invention. See 37 C.F.R. 1.104(a) and 1.106(b) concerning the PTO duty to consider and use any such information. It is respectfully requested that the information be expressly considered during the prosecution of this application, and

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that these references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

Respectfully submitted,

Roger W. Parkhurst

Registration No. 25,177

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FORM 1449 (S&J Version)

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Docket No.: 28931.3420		
Applicant: R. YAMADA et al	10/550	
Application No . New - based on	PCT/IP2064/063894	, I UI

Application No.: New - based on PCT7P2004/003894

Filing Date:

Examiner: Group Art Unit:

		U.S.	PATENT DOCUMENT	S			
Examiner's Initials*	Document No.	Date MM/YYYY	Inventor	Class	Subclass	Filing If Appre	Date opriate
	6,030,581	02/2000	Virtanen	422	68.1		
	5,892,577	04/1999	Gordon	356	73		
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		FOREI	GN PATENT DOCUME	ENTS			
Examiner's	Document No.	Date	Country	Class	Subclass	Transla	
Initials*	Document No.	MM/YYYY	Ouming			Yes	No
	WO 96/09548	03/1996	WIPO				
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		(	THER DOCUMENTS		<u> </u>	4.2	
Examiner's Initials*	Inc	lude author, title volume-issue	of article, title of item (book, joinumber(s), publisher, city and/c	urnal, catalog, or or country wher	etc.), date, page e published.	;e(s), ————	
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Examiner's	Date Considered	
Signature		L

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.